

Notice of References Cited	Application/Control No. 10/685,414		Applicant(s)/Patent Under Reexamination HUCK ET AL.	
	Examiner Andrew Lee		Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,748,611	05-1998	Allen et al.	370/221
*	B	US-6,404,733	06-2002	Shah et al.	370/216
*	C	US-6,990,065	01-2006	Chaudhuri et al.	370/221
*	D	US-6,496,476	12-2002	Badt et al.	370/228
*	E	US-2001/0019536	09-2001	Suzuki, Hiroyuki	370/226
*	F	US-2002/0172150	11-2002	Kano, Shinya	370/216
*	G	US-2002/0006112	01-2002	Jaber et al.	370/238
*	H	US-2002/0131362	09-2002	Callon, Ross	370/216
*	I	US-2002/0167900	11-2002	Mark et al.	370/225
*	J	US-2003/0208572	11-2003	Shah et al.	709/223
*	K	US-2003/0133417	07-2003	BADT, SIG H. JR.	370/254
*	L	US-2004/0057375	03-2004	Shiragaki et al.	370/216
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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